

**RoHS Recast Compliant**  
**Industrial MicroSD**  
R1 Product Specifications

**September 16, 2020**

**Version 1.8**



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## Specifications Overview:

- **Fully Compatible with SD Card Specifications 3.0, 2.0 and 1.1**
  - Part 1, Physical Layer Specification, Ver 3.00 Final
  - Part 2, File System Specification, Ver 3.00
  - Part 3, Security Specification, Ver 3.00 Final
- **Capacity**
  - SD 2.0: 1, 2 GB
  - SD 3.0: 4, 8 GB
- **Performance\***
  - Sequential read: Up to 34 MB/sec
  - Sequential write: Up to 28 MB/sec
- **Flash Management**
  - Built-in advanced ECC algorithm
  - Global Wear Leveling
  - Flash bad-block management
  - Power Management
  - S.M.A.R.T.
  - Page Mapping
  - Power Failure Management
- **SD-Protocol Compatible**
- **Supports SD SPI Mode**
- **NAND Flash Type: SLC**
- **Temperature Range**
  - Operating: -40°C to 85°C
  - Storage: -40°C to 85°C
- **Operating Voltage: 2.7V ~ 3.6V**
- **Power Consumption\***
  - Operating: 115 mA
  - Standby: 265  $\mu$ A
- **Standard Interface**
  - 8-pin SD interface
- **Bus Speed Mode: Supports Class 6 and Class 10 with UHS-I\*\***
  - DS: Default Speed up to 25MHz 3.3V signaling
  - HS: High Speed up to 50MHz 3.3V signaling
  - SDR12: SDR up to 25MHz 1.8V signaling
  - SDR25: SDR up to 50MHz 1.8V signaling
  - SDR50: SDR up to 100MHz 1.8V signaling
  - SDR104: SDR up to 208MHz 1.8V signaling
  - DDR50: DDR up to 50MHz 1.8V signaling
- **Physical Dimensions**
  - 15mm (L) x 11mm (W) x 1mm (H)
- **RoHS Recast Compliant (2011/65/EU)**

\*Performance values presented here are typical and measured based on USB 3.0 card reader. The results may vary depending on settings and platforms.

\*\*Class 6 is only supported on 1GB and 2GB. Timing in 1.8V signaling is different from that of 3.3V signaling. Operation mode selection command is compliant with SD 3.0, referring to SDA's Part 1, Physical Layer Specification, Ver 3.01 (Section 3.9).

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# 1. General Descriptions

As the demand of reliable and high-performance data storage in a small form factor increases, Apacer’s MicroSD card is designed specifically for multiple applications by offering high endurance, reliability, and agility, where extreme flexibility, endurance, data integrity, and exceptionally transmission are required.

The MicroSD card fully complies with SD Card Association standard. The Command List is compatible with [Part 1 Physical Layer Specification Ver3.0 Final] definitions, while the Card Capacity of Non-secure Area, Secure Area supports [Part 3 Security Specification Ver3.0 Final] Specifications. The card allows selection of either SD or SPI mode for compatibility in data communication.

The card also comes with endurance features for data error detection and correction.

## 1.1 Product Functional Block

The MicroSD contains a card controller and a memory core for the SD standard interface.

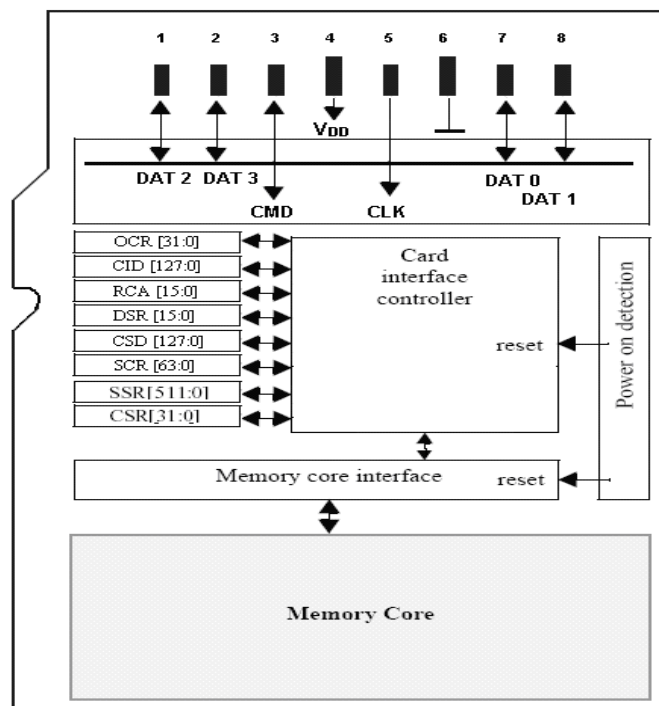


Figure 1-1 Functional Block Diagram

## 1.2 Flash Management

### 1.2.1 Bad Block Management

Bad blocks are blocks that include one or more invalid bits, and their reliability is not guaranteed. Blocks that are identified and marked as bad by the manufacturer are referred to as “Initial Bad Blocks”. Bad blocks that are developed during the lifespan of the flash are named “Later Bad Blocks”. Apacer implements an efficient bad block management algorithm to detect the factory-produced bad blocks and manages any bad blocks that appear with use. This practice further prevents data being stored into bad blocks and improves the data reliability.

### 1.2.2 ECC Algorithms

Flash memory cells will deteriorate with use, which might generate random bit errors in the stored data. Thus, the MicroSD card applies the BCH ECC Algorithm, which can detect and correct errors occur during read process, ensure data been read correctly, as well as protect data from corruption. The MicroSD controller can detect and correct up to 43 bits error in 1K bytes.

### 1.2.3 Power Management

A power saving feature of the MicroSD is automatic entrance and exit from sleep mode. Upon completion of an operation, the SD will enter the sleep mode to conserve power if no further commands are received within X seconds, where X is programmable by software. The master does not have to take any action for this to occur. The SD is in sleep mode except when the host is accessing it, thus conserving power.

Any command issued by the master to the MicroSD will cause it to exit sleep mode and response to the master.

### 1.2.4 S.M.A.R.T.

S.M.A.R.T. (SMART), an acronym stands for Self-Monitoring, Analysis and Reporting Technology, is an open standard allowing an individual disk drive in the ATA/IDE or SCSI interface to automatically monitor its own health and report potential problems in order to prevent data loss. This failure warning technology provides predictions from unscheduled downtime by observing and storing critical drive performance and calibration parameters. Ideally, this should allow taking hands-on actions to keep from impending drive failure.

Failures are divided into two categories: those that can be predicted and those that cannot. Predictable failures occur gradually over time, and the decline in performance can be detected; on the other hand, unpredictable failures happen very sudden without any warning. These failures may be caused by power surges or related to electronic components. The purpose of the SMART implementation is to predict near-term failures of each individual disk drive and generate a warning to prevent unfortunate loss.

### 1.2.5 Global Wear Leveling

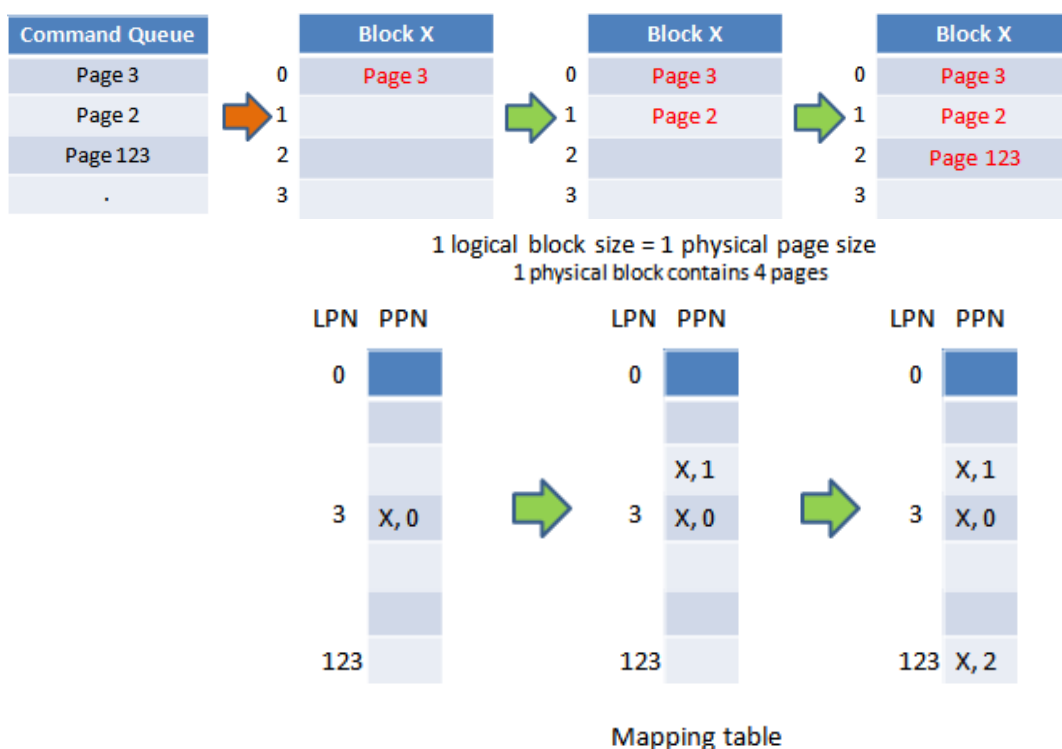
NAND Flash devices can only undergo a limited number of program/erase cycles, and in most cases, the flash media are not used evenly. If some area get updated more frequently than others, the lifetime of the device would be reduced significantly. Thus, Global Wear Leveling technique is applied to extend the lifespan of NAND Flash by evenly distributing writes and erase cycles across the media.

Apacer provides Global Wear Leveling algorithm, which can efficiently spread out the flash usage through the whole flash media area. Moreover, by implementing Global Wear Leveling algorithm, the life expectancy of the NAND Flash is greatly improved.

### 1.2.6 Page Mapping

Page-level mapping uses one page as the unit of mapping. The most important characteristic of page-level mapping is that each logical page can be mapped to any physical page on the flash memory device. This mapping algorithm allows different size of data to be written to a block as if the data is written to a data pool and it does not need to take extra operations to process a write command. The below example shows how page-level mapping performs a write command:

Host instructs three write commands: page 3, 2, and 123. The three pages are written into block X in sequence of command queue. Once all write commands are completed, the mapping table updates itself automatically.



Note: The example only shows the concept of how page-level mapping work and do not necessary happen in an actual case.

This fine-grained page-level mapping scheme makes better capability for handling random data, and increases overall performance and endurance significantly. However, page-level mapping requires SSDs to incorporate a larger RAM in order to maintain its mapping table.

### 1.2.7 Power Failure Management

Apacer industrial SD and microSD cards provide complete data protection mechanism during every abnormal power shutdown situation, such as power failure at programming data, updating system tables, erasing blocks, etc. Apacer Power-Loss Protection mechanism includes:

- Maintaining data correctness and increasing the reliability of the data stored in the NAND Flash memory.
- Protecting F/W table and the data written to flash from data loss in the event of power off.

## 2. Product Specifications

### 2.1 Card Architecture

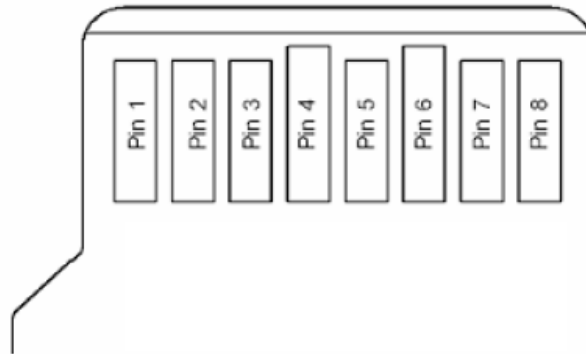


Figure 2-1 Card Architecture

### 2.2 Pin Assignment

Table 2-1 Pin Descriptions

| Pin | SD Mode |                              | SPI Mode |                        |
|-----|---------|------------------------------|----------|------------------------|
|     | Name    | Description                  | Name     | Description            |
| 1   | DAT2    | Data Line[Bit 2]             | RSV      | Reserved               |
| 2   | CD/DAT3 | Card Detect/Data Line[Bit 3] | CS       | Chip Select (neg true) |
| 3   | CMD     | Command/Response             | DI       | Data In                |
| 4   | VDD     | Supply Voltage               | VDD      | Supply Voltage         |
| 5   | CLK     | Clock                        | SCLK     | Clock                  |
| 6   | VSS     | Supply Voltage Ground        | VSS      | Supply Voltage Ground  |
| 7   | DAT0    | Data Line[Bit 0]             | DO       | Data Out               |
| 8   | DAT1    | Data Line[Bit 1]             | RSV      | Reserved               |

## 2.3 Capacity Specifications

The following table shows the specific capacity for the SD 6.1 card.

**Table 2-2** Capacity Specifications

| Capacity | Total bytes*  |
|----------|---------------|
| 1 GB     | 969,605,120   |
| 2 GB     | 1,938,489,344 |
| 4 GB     | 3,875,504,128 |
| 8 GB     | 7,751,041,024 |

Note: Total bytes are viewed under Windows operating system and were measured by SD format too.

## 2.4 Performance Specifications

Performances of the SD 6.1 card are shown in the table below.

**Table 2-3** Performance Specifications

| Capacity                        | 1 GB | 2 GB | 4 GB | 8 GB |
|---------------------------------|------|------|------|------|
| Performance                     |      |      |      |      |
| <b>Sequential Read* (MB/s)</b>  | 23   | 23   | 34   | 33   |
| <b>Sequential Write* (MB/s)</b> | 16   | 18   | 28   | 28   |

Note: Results may differ from various flash configurations or host system setting.

## 2.5 Electrical Specifications

**Table 2-4** Operating Voltages

| Symbol          | Parameter            | Min. | Max. | Unit |
|-----------------|----------------------|------|------|------|
| V <sub>DD</sub> | Power Supply Voltage | 2.7  | 3.6  | V    |

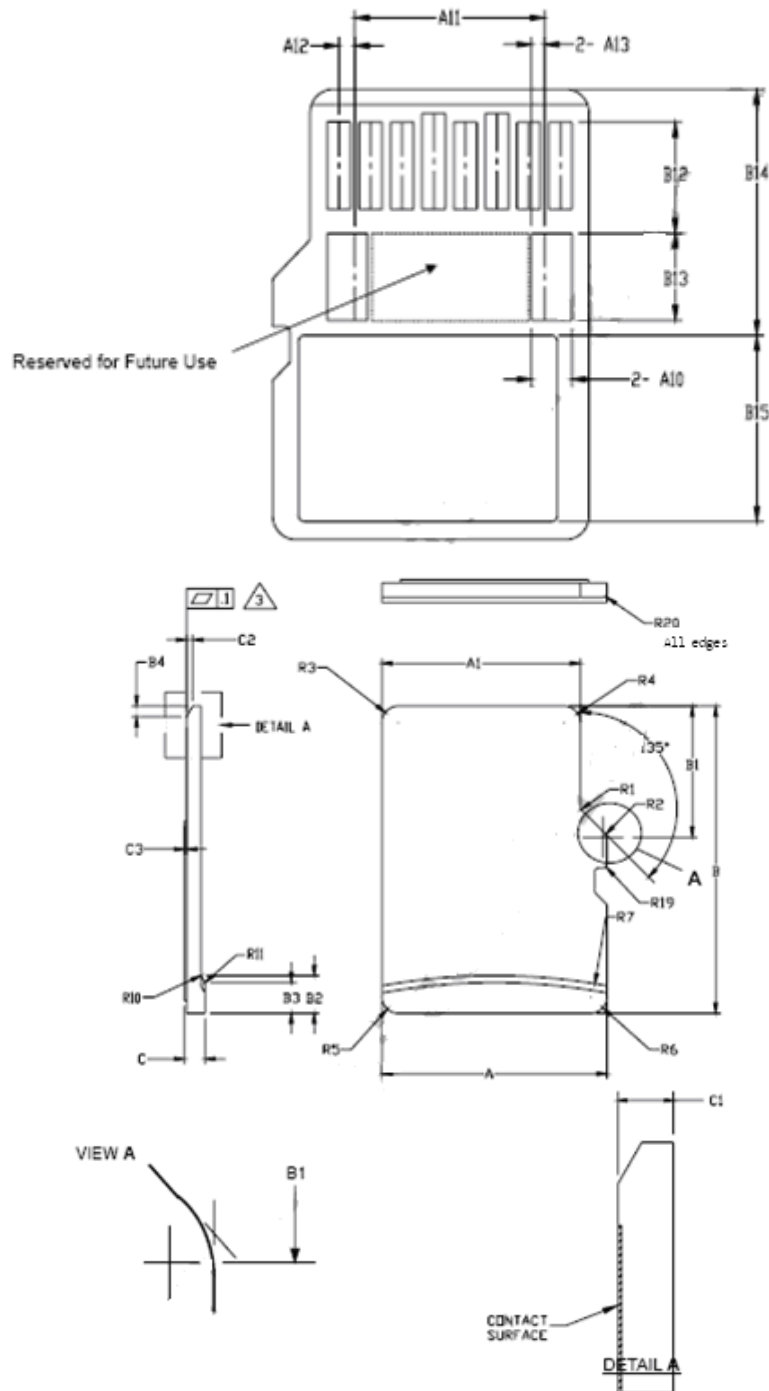
**Table 2-5** Power Consumption

| Capacity              | 1 GB | 2 GB | 4 GB | 8 GB |
|-----------------------|------|------|------|------|
| Mode                  |      |      |      |      |
| <b>Operating (mA)</b> | 110  | 110  | 110  | 115  |
| <b>Standby (μA)</b>   | 160  | 160  | 260  | 265  |

Note: All values are typical and may vary depending on flash configurations or host system settings.


### 3. Physical Characteristics

#### 3.1 Physical Dimensions



| SYMBOL | COMMON DIMENSIONS |       |       | NOTE  |
|--------|-------------------|-------|-------|-------|
|        | MIN               | NOM   | MAX   |       |
| A      | 10.90             | 11.00 | 11.10 |       |
| A1     | 9.60              | 9.70  | 9.80  |       |
| A2     | -                 | 3.85  | -     | BASIC |
| A3     | 7.60              | 7.70  | 7.80  |       |
| A4     | -                 | 1.10  | -     | BASIC |
| A5     | 0.75              | 0.80  | 0.85  |       |
| A6     | -                 | -     | 8.50  |       |
| A7     | 0.90              | -     | -     |       |
| A8     | 0.60              | 0.70  | 0.80  |       |
| A9     | 0.80              | -     | -     |       |
| A10    | 1.35              | 1.40  | 1.45  |       |
| A11    | 6.50              | 6.60  | 6.70  |       |
| A12    | 0.50              | 0.55  | 0.60  |       |
| A13    | 0.40              | 0.45  | 0.50  |       |
| B      | 14.90             | 15.00 | 15.10 |       |
| B1     | 6.30              | 6.40  | 6.50  |       |
| B2     | 1.64              | 1.84  | 2.04  |       |
| B3     | 1.30              | 1.50  | 1.70  |       |
| B4     | 0.42              | 0.52  | 0.62  |       |
| B5     | 2.80              | 2.90  | 3.00  |       |
| B6     | 5.50              | -     | -     |       |
| B7     | 0.20              | 0.30  | 0.40  |       |
| B8     | 1.00              | 1.10  | 1.20  |       |
| B9     | -                 | -     | 9.00  |       |
| B10    | 7.80              | 7.90  | 8.00  |       |
| B11    | 1.10              | 1.20  | 1.30  |       |
| B12    | 3.60              | 3.70  | 3.80  |       |
| B13    | 2.80              | 2.90  | 3.00  |       |
| B14    | 8.20              | -     | -     |       |
| B15    | -                 | -     | 6.20  |       |
| C      | 0.90              | 1.00  | 1.10  |       |
| C1     | 0.60              | 0.70  | 0.80  |       |
| C2     | 0.20              | 0.30  | 0.40  |       |
| C3     | 0.00              | -     | 0.15  |       |
| D1     | 1.00              | -     | -     |       |
| D2     | 1.00              | -     | -     |       |
| D3     | 1.00              | -     | -     |       |
| R1     | 0.20              | 0.40  | 0.60  |       |
| R2     | 0.20              | 0.40  | 0.60  |       |
| R3     | 0.70              | 0.80  | 0.90  |       |
| R4     | 0.70              | 0.80  | 0.90  |       |
| R5     | 0.70              | 0.80  | 0.90  |       |
| R6     | 0.70              | 0.80  | 0.90  |       |
| R7     | 29.50             | 30.00 | 30.50 |       |
| R10    | -                 | 0.20  | -     |       |
| R11    | -                 | 0.20  | -     |       |
| R17    | 0.10              | 0.20  | 0.30  |       |
| R18    | 0.20              | 0.40  | 0.60  |       |
| R19    | 0.05              | -     | 0.20  |       |
| R20    | 0.02              | -     | 0.15  |       |

Notes:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
2. DIMENSIONS ARE IN MILLIMETERS.
3.  COPLANARITY IS ADDITIVE TO C1 MAX THICKNESS.

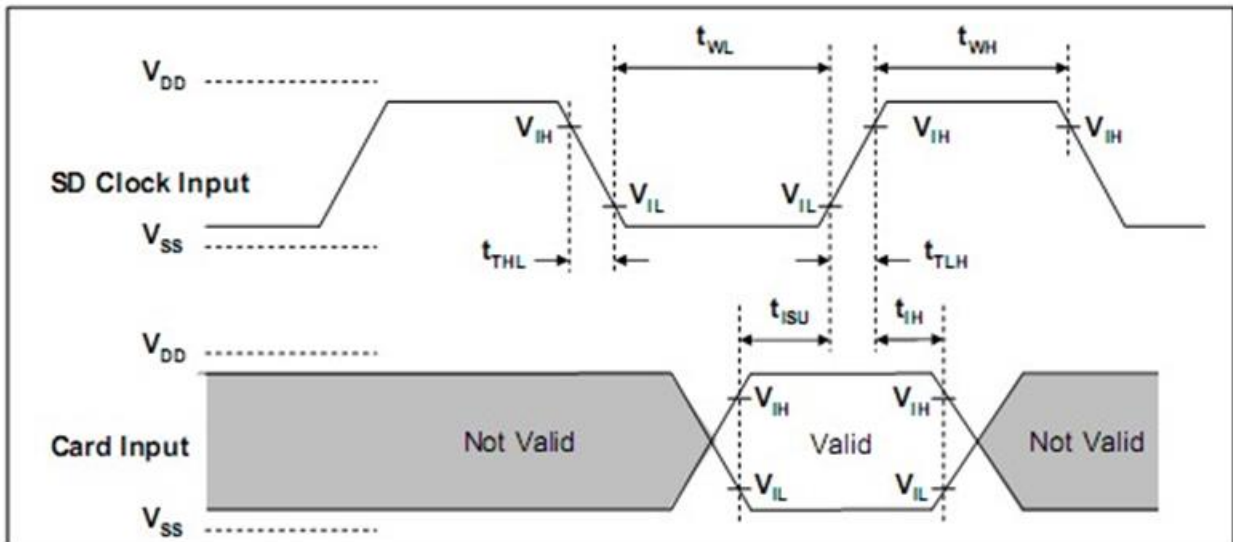
### 3.2 Durability Specifications

**Table 3-1** Durability Specifications

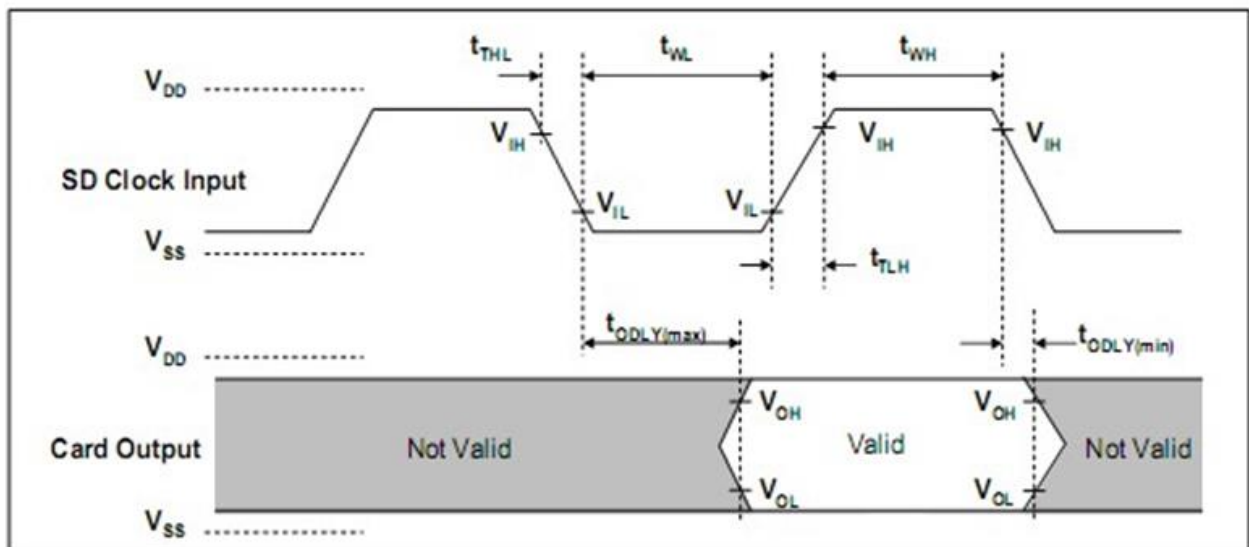
| Item           | Specifications   |
|----------------|--|
| Temperature    | -40°C to 85°C (Operating)  |
|                | -40°C to 85°C (Storage)  |
| Shock          | 1,500G, 0.5ms  |
| Vibration      | 20Hz~80Hz/1.52mm (frequency/displacement)<br>80Hz~2000Hz/20G (frequency/displacement)<br>X, Y, Z axis/60mins each                                |
| Drop           | 150cm free fall, 6 face of each  |
| Bending        | ≥ 10N, hold 1min/5times  |
| Torque         | 0.1N-m or 2.5deg, hold 5min/5times   |
| Salt Spray     | Concentration: 3% NaCl at 35°C (storage for 24 hours)  |
| Waterproof     | JIS IPX7 compliance<br>Water temperature 25°C<br>Water depth: the lowest point of unit is locating 1000mm below surface<br>(storage for 30 mins) |
| X-Ray Exposure | 0.1 Gy of medium-energy radiation (70 KeV to 140 KeV, cumulative dose per year) to both sides of the card (storage for 30 mins)                  |
| Durability     | 10,000 times mating cycle  |
| ESD            | Pass   |

## 4. AC Characteristics

### 4.1 MicroSD Interface Timing (Default)



Card input Timing (Default Speed Card)

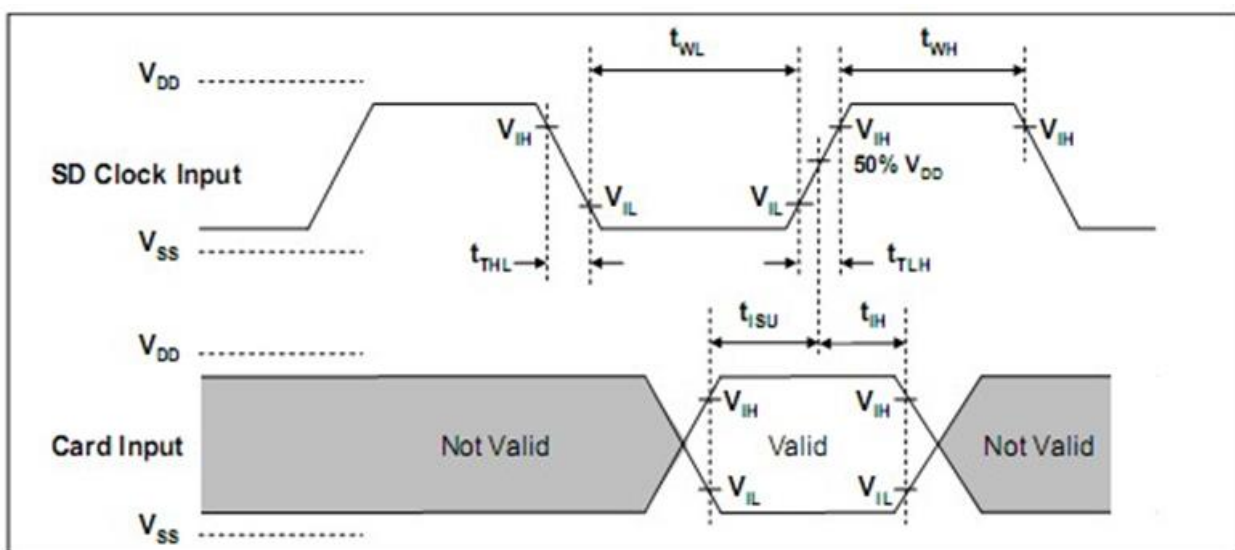


Card Output Timing (Default Speed Mode)

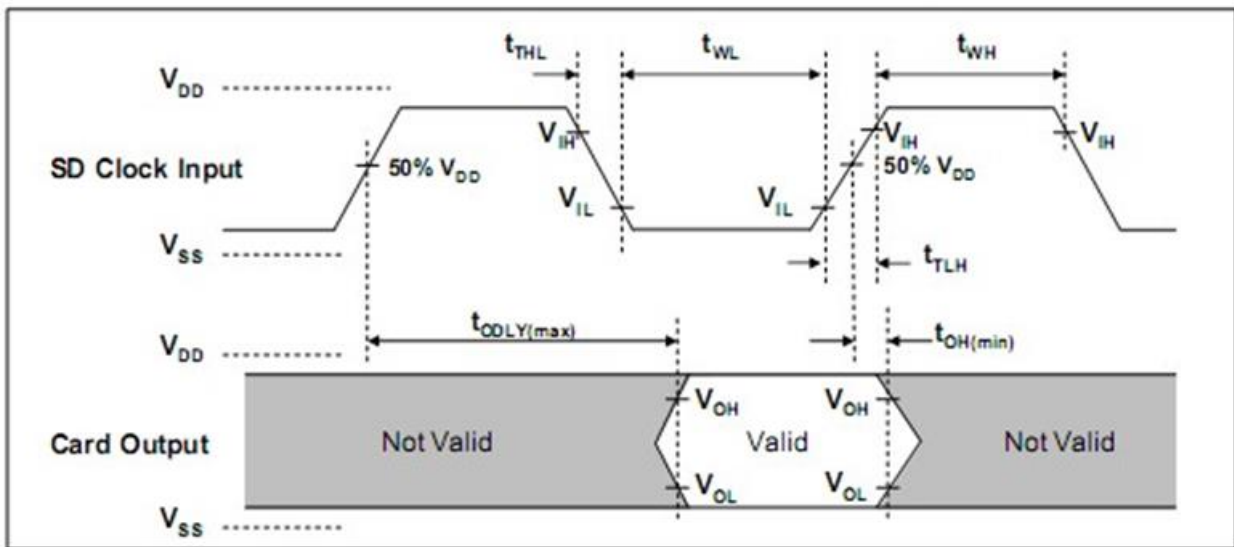
| SYMBOL  | PARAMETER                                   | MIN                   | MAX | UNIT | REMARK                                |
|---|---|-----------------------|-----|------|---------------------------------------|
| <b>Clock CLK (All values are referred to min(V<sub>IH</sub>) and max(V<sub>IL</sub>))</b> |   |                       |     |      |                                       |
| f <sub>PP</sub>   | Clock frequency data transfer               | 0                     | 25  | MHz  | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| f <sub>OD</sub>   | Clock frequency identification              | 0 <sup>(1)</sup> /100 | 400 | KHz  | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| t <sub>WL</sub>   | Clock low time                              | 10                    | -   | ns   | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| t <sub>WH</sub>   | Clock high time                             | 10                    | -   | ns   | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| t <sub>TLH</sub>  | Clock rise time                             | -                     | 10  | ns   | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| t <sub>THL</sub>  | Clock fall time                             | -                     | 10  | ns   | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| <b>Inputs CMD, DAT (Referenced to CLK)</b>  |   |                       |     |      |                                       |
| t <sub>ISU</sub>  | Input setup time                            | 5                     | -   | ns   | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| t <sub>IH</sub>   | Input hold time                             | 5                     | -   | ns   | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| <b>Outputs CMD, DAT (Referenced to CLK)</b>   |   |                       |     |      |                                       |
| t <sub>ODLY</sub>   | Output delay time during data transfer mode | 0                     | 14  | ns   | C <sub>L</sub> ≤ 40 pF<br>(1 card)    |
| t <sub>OH</sub>   | Output hold time                            | 0                     | 50  | ns   | C <sub>L</sub> ≤ 40 pF<br>(1 card)    |

(1)0Hz means to stop the clock. The given minimum frequency range is for cases that require the clock to be continued.

## 4.2 MicroSD Interface Timing (High Speed Mode)



**Card Input Timing (High Speed Card)**



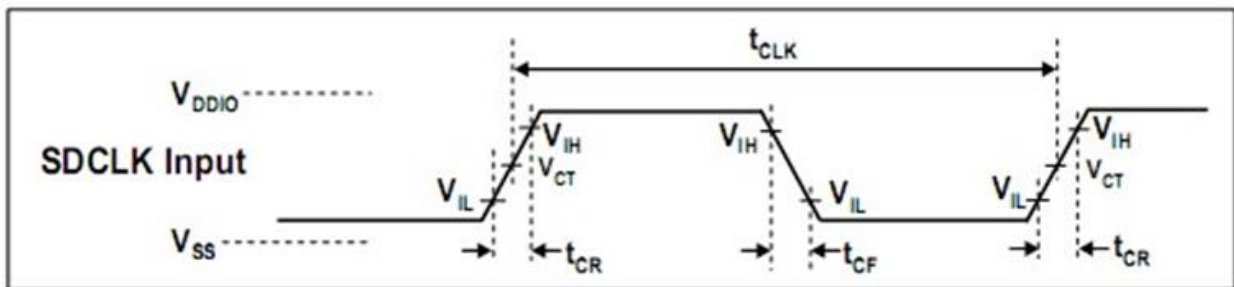
**Card Output Timing (High Speed Mode)**

| SYMBOL  | PARAMETER                                   | MIN | MAX | UNIT | REMARK                                    |
|---|---|-----|-----|------|---|
| <b>Clock CLK (All values are referred to min(<math>V_{IH}</math>) and max(<math>V_{IL}</math>))</b> |   |     |     |      |   |
| $f_{PP}$  | Clock frequency data transfer               | 0   | 50  | MHz  | $C_{card} \leq 10 \text{ pF}$<br>(1 card) |
| $t_{WL}$  | Clock low time                              | 7   | -   | ns   | $C_{card} \leq 10 \text{ pF}$<br>(1 card) |
| $t_{WH}$  | Clock high time                             | 7   | -   | ns   | $C_{card} \leq 10 \text{ pF}$<br>(1 card) |
| $t_{TLH}$   | Clock rise time                             | -   | 3   | ns   | $C_{card} \leq 10 \text{ pF}$<br>(1 card) |
| $t_{THL}$   | Clock fall time                             | -   | 3   | ns   | $C_{card} \leq 10 \text{ pF}$<br>(1 card) |
| <b>Inputs CMD, DAT (Referenced to CLK)</b>  |   |     |     |      |   |
| $t_{ISU}$   | Input setup time                            | 6   | -   | ns   | $C_{card} \leq 10 \text{ pF}$<br>(1 card) |
| $t_{IH}$  | Input hold time                             | 2   | -   | ns   | $C_{card} \leq 10 \text{ pF}$<br>(1 card) |
| <b>Outputs CMD, DAT (Referenced to CLK)</b>   |   |     |     |      |   |
| $t_{ODLY}$  | Output delay time during data transfer made | -   | 14  | ns   | $CL \leq 40 \text{ pF}$<br>(1 card)       |
| $t_{OH}$  | Output hold time                            | 2.5 | -   | ns   | $CL \geq 15 \text{ pF}$<br>(1 card)       |
| CL  | Total system capacitance for each line*     | -   | 40  | pF   | 1 card                                    |

\*In order to satisfy severe timing, host shall run on only one card

### 4.3 MicroSD Interface Timing (SDR12, SDR25, SDR50 and SDR104 Modes)

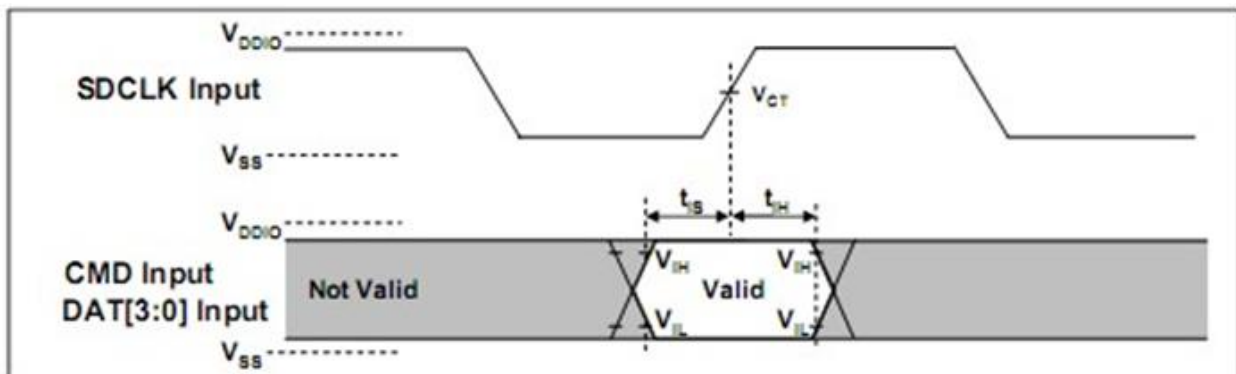
#### 4.3.1 Clock Timing



**Clock Signal Timing**

| SYMBOL           | MIN | MAX             | UNIT | REMARK  |
|------------------|-----|-----------------|------|---|
| $t_{CLK}$        | 4.8 | -               | ns   | 208MHz (Max.), Between rising edge, $V_{CT} = 0.975V$   |
| $t_{CR}, t_{CF}$ | -   | $0.2 * t_{CLK}$ | ns   | $t_{CR}, t_{CF} < 2.00ns$ (max.) at 208MHz, $C_{CARD}=10pF$<br>$t_{CR}, t_{CF} < 2.00ns$ (max.) at 100MHz, $C_{CARD}=10pF$<br>The absolute maximum value of $t_{CR}, t_{CF}$ is 10ns regardless of clock frequency. |
| Clock Duty       | 30  | 70              | %    |   |

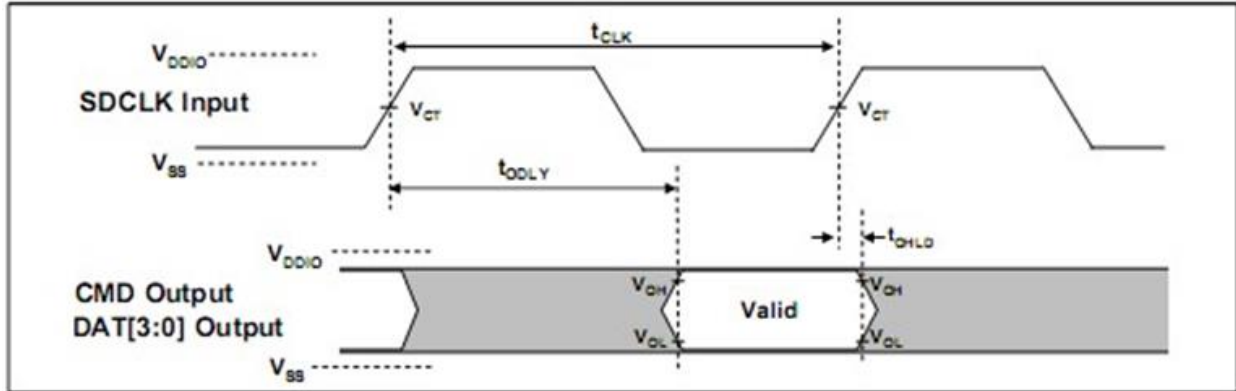
#### 4.3.2 Card Input Timing



**Card Input Timing**

| SYMBOL   | MIN  | MAX | UNIT | SDR104 MODE                        |
|----------|------|-----|------|------------------------------------|
| $t_{IS}$ | 1.40 | -   | ns   | $C_{CARD} = 10pF, V_{CT} = 0.975V$ |
| $t_{IH}$ | 0.80 | -   | ns   | $C_{CARD} = 5pF, V_{CT} = 0.975V$  |
| SYMBOL   | MIN  | MAX | UNIT | SDR12, SDR25 and SDR50 MODES       |
| $t_{IS}$ | 3.00 | -   | ns   | $C_{CARD} = 10pF, V_{CT} = 0.975V$ |
| $t_{IH}$ | 0.80 | -   | ns   | $C_{CARD} = 5pF, V_{CT} = 0.975V$  |

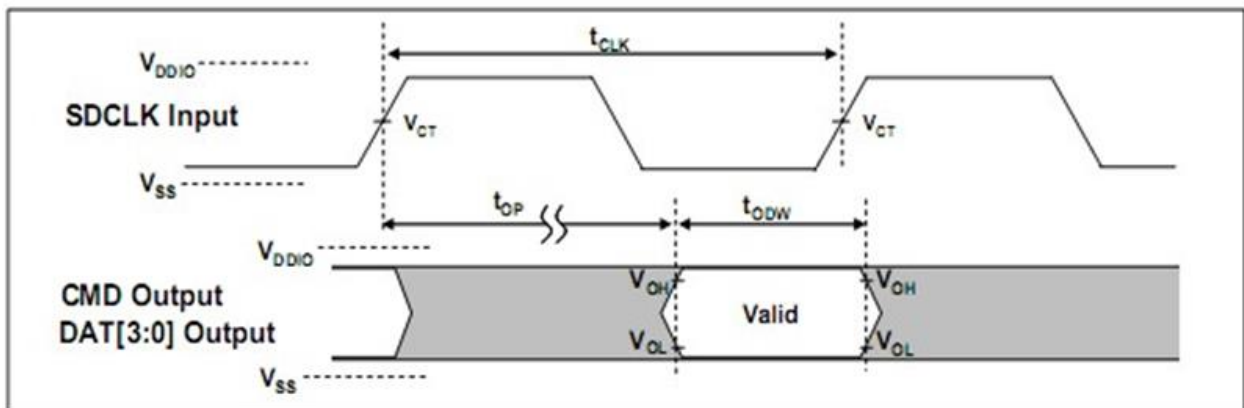
### 4.3.3 Card Output Timing of Fixed Data Window (SDR12, SDR25 and SDR50)



Output Timing of Fixed Date Window<sup>+</sup>

| SYMBOL     | MIN | MAX | UNIT | REMARK  |
|------------|-----|-----|------|---|
| $t_{ODLY}$ | -   | 7.5 | ns   | $t_{CLK} \geq 10.0ns$ , $CL=30pF$ , using driver Type B, for SDR50.           |
| $t_{ODLY}$ |     | 14  | ns   | $t_{CLK} \geq 20.0ns$ , $CL=40pF$ , using driver Type B, for SDR25 and SDR12. |
| $t_{OH}$   | 1.5 | -   | ns   | Hold time at the $t_{ODLY}$ (min.). $CL=15pF$                                 |

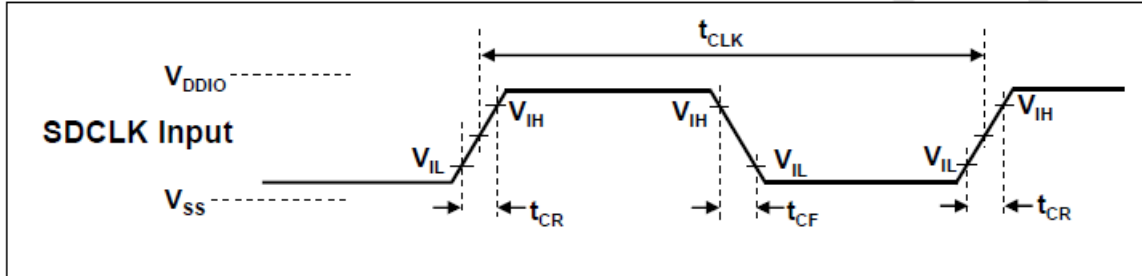
### 4.3.4 Output Timing of Variable Window (SDR104)



Output Timing of Variable Data Window<sup>+</sup>

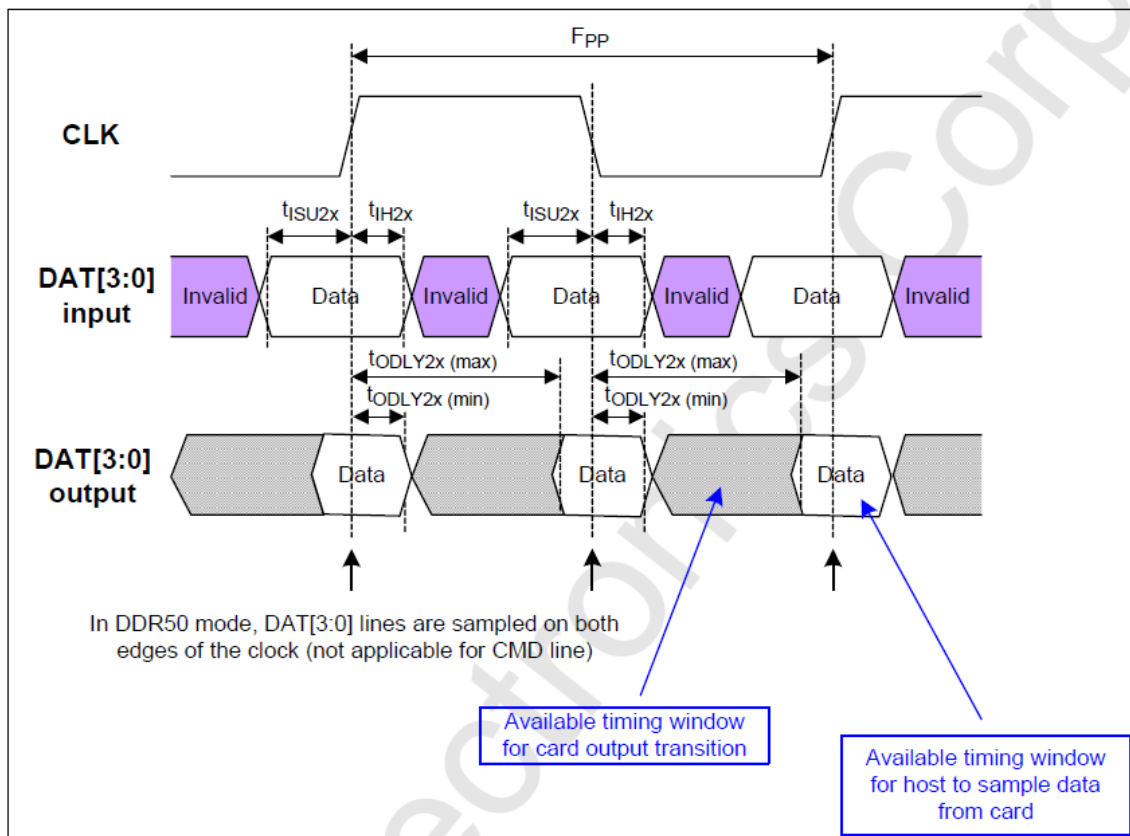
| SYMBOL          | MIN  | MAX   | UNIT | REMARK   |
|-----------------|------|-------|------|--|
| $t_{OP}$        | -    | 2     | UI   | Card Output Phase                                      |
| $\Delta t_{OP}$ | -350 | +1550 | ps   | Delay variation due to temperature change after tuning |
| $t_{ODW}$       | 0.60 | -     | UI   | $t_{ODW} = 2.88ns$ at 208MHz                           |

### 4.3.5 SD Interface Timing (DDR50 Mode)



**Clock Signal Timing**

| SYMBOL           | MIN | MAX                 | UNIT | REMARK   |
|------------------|-----|---------------------|------|--|
| $t_{CLK}$        | 20  | -                   | ns   | 50MHz (Max.), Between rising edge                            |
| $t_{CR}, t_{CF}$ | -   | $0.2 \cdot t_{CLK}$ | ns   | $t_{CR}, t_{CF} < 4.00\text{ns (max.)}$ at 50MHz, CCARD=10pF |
| Clock Duty       | 45  | 55                  | %    |  |



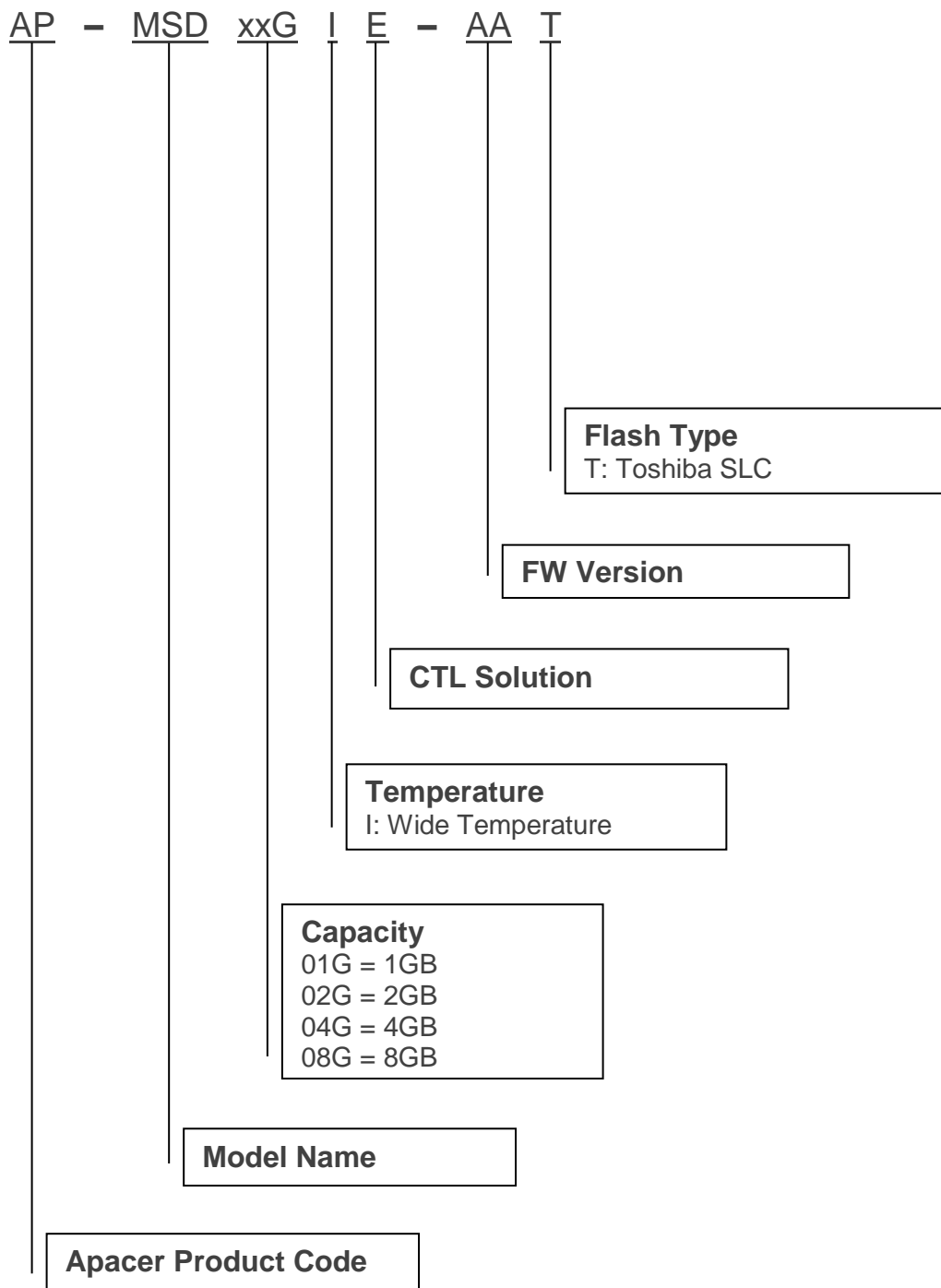
**Timing Diagram DAT Inputs/Outputs Referenced to CLK in DDR50 Mode**

### 4.3.6 Bus Timings – Parameters Values (DDR50 Mode)

| Symbol  | Parameters                                  | Min | Max  | Unit | Remark                                |
|---|---|-----|------|------|---------------------------------------|
| <b>Input CMD</b> (referenced to CLK rising edge)                |   |     |      |      |                                       |
| t <sub>ISU</sub>  | Input set-up time                           | 6   | -    | ns   | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| t <sub>IH</sub>   | Input hold time                             | 0.8 | -    | ns   | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| <b>Output CMD</b> (referenced to CLK rising edge)               |   |     |      |      |                                       |
| t <sub>ODLY</sub>   | Output Delay time during Data Transfer Mode | -   | 13.7 | ns   | C <sub>L</sub> ≤ 30 pF<br>(1 card)    |
| T <sub>OH</sub>   | Output Hold time                            | 1.5 | -    | ns   | C <sub>L</sub> ≥ 15 pF<br>(1 card)    |
| <b>Inputs DAT</b> (referenced to CLK rising and falling edges)  |   |     |      |      |                                       |
| t <sub>ISU2x</sub>  | Input set-up time                           | 3   | -    | ns   | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| t <sub>IH2x</sub>   | Input hold time                             | 0.8 | -    | ns   | C <sub>card</sub> ≤ 10 pF<br>(1 card) |
| <b>Outputs DAT</b> (referenced to CLK rising and falling edges) |   |     |      |      |                                       |
| t <sub>ODLY2x</sub>   | Output Delay time during Data Transfer Mode | -   | 7.0  | ns   | C <sub>L</sub> ≤ 25 pF<br>(1 card)    |
| T <sub>OH2x</sub>   | Output Hold time                            | 1.5 | -    | ns   | C <sub>L</sub> ≥ 15 pF<br>(1 card)    |

## 5. Product Ordering Information

### 5.1 Product Code Designations



## 5.2 Valid Combinations

| Capacity | Part Number     |
|----------|-----------------|
| 1GB      | AP-MSD01GIE-AAT |
| 2GB      | AP-MSD02GIE-AAT |
| 4GB      | AP-MSD04GIE-AAT |
| 8GB      | AP-MSD08GIE-AAT |

**Note:** Valid combinations are those products in mass production or will be in mass production. Consult your Apacer sales representative to confirm availability of valid combinations and to determine availability of new combinations.

## Revision History

| Revision | Description   | Date       |
|----------|---|------------|
| 1.0      | Official release  | 12/22/2015 |
| 1.1      | - Added S.M.A.R.T. chapter<br>- Revised product ordering information  | 1/13/2016  |
| 1.2      | Specified supported capacity for SD 2.0 and SD 3.0 respectively   | 1/18/2016  |
| 1.3      | Removed S.M.A.R.T. chapter  | 2/1/2016   |
| 1.4      | Added support for page mapping  | 6/7/2016   |
| 1.5      | Added Power Failure Management to Features and General Description  | 10/3/2016  |
| 1.6      | Removed "The data written at the exact moment power off will be lost, and the max data loss is 16 sectors." from 1.2.7 Power Failure Management | 10/7/2016  |
| 1.7      | Added bus speed mode support to Specifications Overview   | 8/25/2020  |
| 1.8      | Updated 1.2.2 Powerful ECC Algorithms   | 9/16/2020  |

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